

Search Notes**Application/Control No.**

10/820,970

Examiner

Ren L. Yan

Applicant(s)/Patent under Reexamination

BONELLA, ANDREA

Art Unit

2854

SEARCHED

Class	Subclass	Date	Examiner
101	33 34		
	483		
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347	224		
<i>Search updated</i>		8/20/06	RY

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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INTERFERENCE SEARCHED

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interference search print out		8/20/2006	RY